

# EAST Search History + *Interference*

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	1	(apparatus and (total adj reflection) and (half adj reflection) and (secondary adj lighting))	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:12
L2	4	(apparatus and (printed adj circuit adj board) and ((half adj reflection) half\$1reflection))	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:15
L3	1	(apparatus and (printed adj circuit adj board) and ((half adj reflection) half\$1reflection)).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:15
L4	1	(apparatus and (circuit adj board) and ((half adj reflection) half\$1reflection)).clm.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:15
L5	857784	(inspect\$4 detect\$4 analyz\$6 review determin\$6) with (flaw error good bad problem defect impurity)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 08:58
L6	63691	L5 with (board chip wafer substrate disk)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 08:58
L9	77741	(axis rotate) with (mirror beam\$split\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 08:59
L10	95914	(location position) with (mirror beam\$split\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 08:59
L11	23360	9 same 10	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 08:59

## EAST Search History

L12	57448	(mirror with (axis angle orientation)) same (area region location position scan)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 09:00
L13	720	6 and 11 and L12	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 09:05
L14	89	13 and (circuit board).ab.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 09:06
S1	1	"529953" and jeong.in.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/20 13:56
S2	2	((("6043876") or ("5105149"))).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	OFF	2007/12/07 07:11
S3	1	("59137803").PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	OFF	2007/11/20 14:12
S4	2	((("4152723") or ("5489985"))).PN.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	OFF	2007/11/20 14:16
S5	854843	(inspect\$4 detect\$4 analyz\$6 review determin\$6) with (flaw error good bad problem defect impurity)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 08:58
S6	332952	((inspect\$4 detect\$4 analyz\$6 review determin\$6) with (flaw error good bad problem defect impurity)). ab.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 09:00
S7	4415180	(light\$4 illuminat\$4 laser LED radiat\$4)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 09:01

## EAST Search History

S9	63428	S5 with (board chip wafer substrate disk)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:07
S10	23297	S6 with (board chip wafer substrate disk)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 09:19
S11	4212488	(board chip wafer substrate disk)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 09:20
S12	2742248	(camera photograph\$4 image)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 09:21
S13	253506	S12 with S11	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 09:22
S14	749825	(comput\$4 process\$4 compar\$4) with S12	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 09:23
S15	624346	mirror	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:07
S17	359	S10 and S13 and S14 and S15	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 06:57
S18	34	S17 and (circuit adj board)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:09
S19	76599	(axis rotate) with mirror	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 11:35

## EAST Search History

S20	96	S17 and ((axis rotate) with mirror)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 11:36
S21	10	S18 and ((axis rotate) with mirror)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/21 11:36
S22	57283	(mirror with (axis angle orientation)) same (area region location position scan)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08
S23	332985	((inspect\$4 detect\$4 analyz\$6 review determin\$6) with (flaw error good bad problem defect impurity)). ab.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08
S24	23303	S23 with (board chip wafer substrate disk)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08
S25	4215176	(board chip wafer substrate disk)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08
S26	2743836	(camera photograph\$4 image)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08
S27	253781	S26 with S25	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08
S28	750562	(comput\$4 process\$4 compar\$4) with S26	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08
S29	624745	mirror	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:08

## EAST Search History

S30	359	S24 and S27 and S28 and S29	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:10
S31	86	S24 and S27 and S28 and S22	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/11/26 06:10
S32	4282	(356/300,399-401).ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 06:57
S33	4282	(356/300,399-401).ccls.	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:07
S34	857784	(inspect\$4 detect\$4 analyz\$6 review determin\$6) with (flaw error good bad problem defect impurity)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:07
S35	63691	S34 with (board chip wafer substrate disk)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:08
S36	76874	(axis rotate) with mirror	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:08
S37	2028	S34 and S35 and S36	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:08
S38	199	S33 and S37	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:08
S39	4	S38 and (circuit adj board)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:09

## EAST Search History

S40	207	S33 and (circuit adj board)	US-PGPUB; USPAT; USOCR; EPO; JPO; IBM_TDB	OR	ON	2007/12/07 07:09
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